

Notice of References Cited	Application/Control No. 10/595,523		Applicant(s)/Patent Under Reexamination NAKAYAMA ET AL.	
	Examiner JAE LEE		Art Unit 2823	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0106217 A1	06-2004	Higgs, Victor	438/005
*	B	US-2004/0213309 A9	10-2004	Amano et al.	372/045
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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